

<b>Notice of References Cited</b>	Application/Control No. 10/003,149	Applicant(s)/Patent Under Reexamination DIMATTEO ET AL.	
	Examiner (Jackie) Tan-Uyen T. Ho	Art Unit 3731	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,695,833	02-2004	Frantzen, John J	623/1.13
	B	US-2003/0082324	05-2003	Sogard et al.	428/36.9
	C	US-2003/0082323	05-2003	Venditti et al.	428/36.9
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP0351584A1	01-1990	EP	ISHIWARI ET AL.	B01D 69/08
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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